		A	PPLICA	ATION F	OR ES	CC QUALIFIC	CATION	APPROVAL			Page	1
E E	SCC	Component Title:				ATOR RK135, le output, RAD		2, 4MHz to 100MHz,		A	Appl. N	0.
		Executive Member	:	CNE	S			Date: 15/02/2027	1		371	
Components (including	g series and families)	submitted for Qualif	ication /	Approva	ıl							1
ESCC COMPONENT. NO.	VARIANTS	RANGE OF	COMP	ONENT	S	BASE	C	TEST VEHICLE / S			ONEN	Т
3503001	05 and 11	DIL package				RK135 type		RK115 DIL1 B2 EQM 13M50000 CONFIG1		Oliv		
	01 to 04 and 06 to 10	FP1, FP2, FP3	and FP	4 packa	ges			RK 115 AC FP4 B2 EM 100M000000 CONFIG2				
								RK135 FP4 B1 EM 13.500000MHz Config 3-2				
								RK 115 FP4 C1 EQM 100M000000				
								RK 115 FP4 C1 100M00000				
Component Ma RAKON France	nufacturer	2 Location 2 Rue Robert K		nufacturi	ng Plan	t 3	E	SCC Specification used f	or Qua	alificatio	on	4
RAKON FIANCE		2 Rue Robert k 10150 Pont-Sa		rie			Gener Issue Detail, Issue	03				
Qualification Report R				5	PID u	used for manuf	facturing	Qualification Lot				6
51001617.520.01-A0, 51001617.520.02-A0, 51001617.520.03-A0, 51001232.570.00-A1, TRAD_TE_RK135FP4 TRAD_TN_RK135FP4 Date: (see abo	20/10/2016 15/01/2019 18/01/2021 IB1EM_1528_TEM_J IB1EM_1528_TEM_J				Ref N Issue Date	e: B0	001742	i				
PID changes since sta	art of qualification		7 (	Current I	PID Ve	erified by		C. Doucet, CN	ES			8
None □ Minor* ⊠			F	Ref No:			Name 51001	of Executive Representa	tive			
	(* Details not publishe confidential annex 2.)			ssue			D0					
	,		[	Date			30/11	/2019				
Current Manufacturing	facilities surveyed by	y:										9
C. Doucet, CNES and	D. Lacombe, ESA		2	20/11/20	019			_				L
(Name of Executive R	esponsible)		(	(Date)								
Rakon-AUD-2019												
Report Ret	ference											
Satisfactory:	Yes 🛛	No 🗆	Expla	ain	Correct	tive actions imp	plement	ed in PID issue D0				
Quality and Reliability	Data											10
Evaluation testing per	formed Yes	No No				ailure analysis vailable	5, DPA, 1	NCCS Yes 🗵	3	No		
Report Ref. No.: 5	1001742.520 Issue A	0 Date:	29/03/2	2016	(\$	supply data)						
Equivalent Data:					C	PA report : 20	-4120-1	00_DPA RK115 FP4 100I	MHz C	C 194	9	
Certification:												
								NC2RAKC2002 – Consta ion tests (already perform				

	AP	PLICATION FOR ESCC QU	ALIFICATION APPROVA	L	Page 2
<b>ESCC</b>	Component Title:	CRYSTAL OSCILLATOR F AHCMOS compatible outp	RK135, CLASS 2, 4MHz to ut, RAD-HARD	100MHz,	Appl. No.
	Executive Member:	CNES	Date:	15/02/2021	371
					11
The undersigned hereby certifies on beha that the appropriate documentation has b					
except as stated in box 13; that the report given to the component(s) listed herein.	ts and data are available	e at the ESCC Executive and	therefore applies for ESC	C qualification statu	is to be
given to the component(s) listed herein.				$\langle \cdot \rangle$	work
Date: 15/02/2021			JP. BUS	SENOT	
			(Signatur	e of the Executive	Coordinator)
Continuation of Boxes above: (Only non-	confidential comments)				12

			APPLICATION FOR ESCC QUALIFICAT	ION APPROVAL	Page 3
Card a	ESCC	Component T	itle: CRYSTAL OSCILLATOR RK135, CLA AHCMOS compatible output, RAD-HA	ASS 2, 4MHz to 100MHz, ARD	Appl. No.
		Executive Me	mber: CNES	Date: 15/02/2021	371
Non compli	ance to ESCC requirements:				13
No.:	Specification		Paragraph	Non compliance	
		mpliance for ES	CC qualification or rationale for acceptability c		14
Executive N	lanager Disposition				15
Application Action / Ren		No 🗆		SH BI Digitall by Britt Date: 2 19:00:2	y signed a Schade 021.02.23 1 +01'00'
Date:				B. Schade: Head of the Product and Safety Departme	Assurance

	AP	PLICATION FOR ESCC QUALIFICATION	APPROVAL		Page 4	
<b>ESCC</b>	Component Title:	CRYSTAL OSCILLATOR RK135, CLASS 2 AHCMOS compatible output, RAD-HARD	2, 4MHz to 1	00MHz,	Appl. No.	
	Executive Member:	CNES	Date:	15/02/2021	371	
ANNEX 1: LIST OF TESTS DONE TO SUF	PPORT QUALIFICATI	ON				16
Tests conducted in compliance with:						
<ul> <li>ESCC 3503 generic specificatio</li> <li>Or PID-TFD</li> <li>Tests vehicle identification/description:</li> </ul>	on; Chart F4 (for ES0 (for ESCC/QML					
RK115 DIL1 B2 EQM 13M50000 CONFI 1524	G1 / DC RK115 A DC 1524	C FP4 B2 EM 100M000000 CONFIG2 /	RK135 FI DC 1528	P4 B1 EM 13M500	000 CONFIG 3-	-2 /
RK 115 FP4 C1 EQM 100M000000 / DC	1728 RK115 F	P4 C1 100M000000 / DC 1949				
Detail Specification reference: 35	03/001 Issue 03					

Chart F4	Test	Tick when	Conditions	Date Code	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
	Mechanical Shock	done	MIL-STD-202, Test Method 213	1524 / 1728 / 1949	41	4	Delta qualification has been run and successfully passed after improvement of the test set-up
dno	Random Vibration	$\boxtimes$	MIL-STD-202, Test Method 214	1524 / 1728 / 1949	37	0	
l Subgi	Constant Acceleration		MIL-STD-883, Test Method 2001		NA		Constant acceleration was removed after issuing a DCR (NC2RAKC2002)
tal/Mechanical (Mechanical)	Temperature Cycling	$\boxtimes$	MIL-STD-883, Test Method 1010	1524 / 1949	23	0	6 parts submitted only to 200 cycles 12 parts submitted to 500 cycles but not to previous mechanical tests
tal/Med (Mecha	Seal (Fine and Gross Leak)		MIL-STD-883, Test Method 1014	1524 / 1949	11	0	
Environmental/Mechanical Subgroup (Mechanical)	Intermediate and End-Point Electrical Measurements	$\boxtimes$	Intermediate and End-Point Electrical Measurements in the Detail Specification	1524 / 1949	12	0	
Ш	External Visual Inspection	$\boxtimes$	ESCC Basic Specification No. 20500	1524 / 1949	12	0	
	DPA	$\boxtimes$	MIL-STD-1580	1524 / 1728 / 1949	10	0	
dn	Thermal Shock		MIL-STD-883, Test Method 1011				
Subgro	Moisture Resistance		MIL-STD-883, Test Method 1004				
inical S ental)	Seal (Fine and Gross Leak)		MIL-STD-883, Test Method 1014				
Environmenta/Mechanical Subgroup (Environmental)	Intermediate and End-Point Electrical Measurements		Intermediate and End-Point Electrical Measurements in the Detail Specification				
Environ	External Visual Inspection		ESCC Basic Specification No. 20500				
dna	Operating Life		MIL-STD-883, Test Method 1005	1524 / 1728	11	0	
Endurance Subgroup	Intermediate and End-Point Electrical Measurements	$\boxtimes$	Intermediate and End-Point Electrical Measurements in the Detail Specification	1524 / 1728	11	0	
duranc	Seal (Fine and Gross Leak)	$\boxtimes$	MIL-STD-883, Test Method 1014	1524	4	0	
Enc	External Visual Inspection	$\boxtimes$	ESCC Basic Specification No. 20500	1524	11	0	

Lead Integrity       MIL-STD-883, Test Method       NA       Aready performed during screening         Solderability       Solderability       MIL-STD-883 Test Method       NA       Aready performed during screening         Solderability       Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Solderability       MIL-STD-883 Test Method       1524       6       0       Solderability test is done at procure         Storage       Quoth MIL-STD-883 Test Method       1524       6       0       3 parts submitted to only 1000h and in intermediate DPA <th></th> <th></th> <th></th> <th>APPLICATION FOR</th> <th>R ESCC QUALI</th> <th>FICATION</th> <th>APPROVAI</th> <th>L</th> <th>Page 5</th>				APPLICATION FOR	R ESCC QUALI	FICATION	APPROVAI	L	Page 5		
Executive Member:       CNES       Date:       15/02/2021       371         Chart F4       Test       Tick when done       Conditions       Date Code       Tested Qty       No. of Rejects       Comments if not performe Comments on Rejection         ugged of the performance of Marking       Rediation       Rest Rest Rest Rest Rest Rest Rest Rest	C Selection	ESCC	Comp				2, 4MHz to	100MHz,	Appl. No.		
Chart F4       Test       when done       Conditions       Date Code       Lested Qty       No. of Rejects       Comments if not performe Comments on Rejection         upper version       Radiation       Image: Section of the se	100		Execu		patible catpat, i		ate: 15/02	2/2021	371		
Lead Integrity       Image: MIL-STD-883, Test Method 2004       NA       Performed at package procurement 2004         External Visual Inspection       Image: Solderability       Esc: Basic Specification No. 20500       NA       Already performed during screening 2003         Permanence of Marking       Image: Solderability       MIL-STD-883 Test Method 2003       NA       Marking done by engraving         Solderability       Image: Solderability       MIL-STD-883 Test Method 2003       1524       6       0       Solderability test is done at procure level. A resistance to solder heat test end (1014)         Internal Water Vapour       Image: MIL-STD-883 Test Method 1014       1524       6       0       Solderability test is done at procure level. A resistance to solder heat test performed instead.         Internal Water Vapour       Image: MIL-STD-883 Test Method 1014       1524       2       0       3 parts submitted to only 1000h and 1018	Chart F4	Test	when	Conditions	Date Code						
Description       Image: Constraint of the system of the sys	Radiation Subgroup	Radiation	$\boxtimes$		1528	15	0				
Internal Water Vapour         Image: Nill-31D 2003 Fest intention         1524         2           1018         2000h @125°C (non-         4504         40         a         3 parts submitted to only 1000h and	٩	Lead Integrity				NA		Performed at package	ge procurement level		
Internal Water Vapour         Image: Nill-31D 2003 Fest intention         1524         2           1018         2000h @125°C (non-         4504         40         a         3 parts submitted to only 1000h and	noıbdır					NA		Already performed c	uring screening		
Internal Water Vapour         Image: Non-State Wethout         1524         2           1018         2000h @125°C (non-         400         a         3 parts submitted to only 1000h and	oility Su	Permanence of Marking				NA		Marking done by en	graving		
Internal Water Vapour         Image: Nill-31D 2003 Fest intention         1524         2           1018         2000h @125°C (non-         4504         40         a         3 parts submitted to only 1000h and	ly Capab	Solderability		2003	1524	6	0	level. A resistance to	lone at procurement o solder heat test is		
Internal Water Vapour         Image: Non-State Wethout         1524         2           1018         2000h @125°C (non-         400         a         3 parts submitted to only 1000h and	ssemb		$\boxtimes$		1524	6	0				
Storage     2000h @125°C (non-operating)     1524     18     0     3 parts submitted to only 1000h and to an intermediate DPA       Image: Description of the storage     Image: Description operating in the storage     Image: Description operating in the storage     Image: Description operating in the storage	Ϋ́ε	Internal Water Vapour	$\boxtimes$		1524	2					
Addition and the state of the s	al	Storage	$\boxtimes$		1524	18	0				
	dditior Tests										
	A										

ENTRIES Form Heading shall indic date; — ti Box 1 shall prov by using t Vehicle ei enter a cr Box 2 and 3 Manufact Box 4 Generic a Box 5 Reference Box 6 Enter det Box 7 If the PID reasons for Box 8 The box s occurrence Box 9 This box 0 in manufa requireme Box 10 Details er has been not been a laternative be made i the Evalue Box 11 Enter the Box 13 Fill table a Box 15 All Execu QML entre Box 16 Fill in Tab	AHCMOS compa Executive Member: CNES	ILLATOR RK135, CLASS 2, 4MHz to 100MHz, atible output, RAD-HARD Date: 15/02/2021 <b>N FORM FOR ESCC QUALIFICATION</b> detail specification or the name of the series or family; – all be listed - the variants or range of variants; the range of designation given in detail specification as 'based on'; capable to identify the component tested;	- the entering of components -under Test
ENTRIES Form Heading shall indic date; — til Box 1 shall prov by using t Vehicle ei enter a cr Box 2 and 3 Manufact Box 4 Generic a Box 5 Reference Box 6 Enter deta Box 7 If the PID reasons for Box 8 The box s occurrence Box 9 This box 0 in manufar requirement Box 10 Details er has been not been a alternative be made i the Evalue Box 11 Enter the Box 13 Fill table a Box 15 All Execu QML entre Box 16 Fill in Tab	PLETION OF THE APPLICATION cate:— the title of the component as given in its he serial number and the suffix of the form. ride details given in table; in particular there sha the ESCC code for values tolerances, etc.; the conter either a cross or the specific characteristic or oss.	N FORM FOR ESCC QUALIFICATION	- the entering of components -under Test
ENTRIES Form Heading shall indic date; — til Box 1 shall prov by using t Vehicle ei enter a cr Box 2 and 3 Manufact Box 4 Generic a Box 5 Reference Box 6 Enter det Box 7 If the PID reasons for Box 8 The box s occurrence Box 9 This box 0 in manufa requireme Box 10 Details er has been not been a lernative be made i the Evalue Box 11 Enter the Box 12 To be use in the rele Box 13 Fill table a Box 15 All Execu QML entr	cate:— the title of the component as given in its he serial number and the suffix of the form. vide details given in table; in particular there sha the ESCC code for values tolerances, etc.; the conter either a cross or the specific characteristic of oss. urer's name and location of plant where the com	detail specification or the name of the series or family; - all be listed - the variants or range of variants; the range of designation given in detail specification as 'based on';	- the entering of components -under Test
date; — tilBox 1shall prov by using til Vehicle ei enter a crBox 2 and 3ManufactBox 4Generic aBox 5ReferenceBox 6Enter detBox 7If the PID reasons frBox 8The box s occurrenceBox 9This box a in manufar requiremeBox 10Details er has been not been alternativa be made i the EvalueBox 11Enter theBox 12To be use in the releBox 13Fill table a Box 15Box 16Fill in Tab	he serial number and the suffix of the form. ride details given in table; in particular there sha the ESCC code for values tolerances, etc.; the c nter either a cross or the specific characteristic o ross. urer's name and location of plant where the com	all be listed - the variants or range of variants; the range designation given in detail specification as 'based on';	of components -under Test
date; — tilBox 1shall prov by using til Vehicle ei enter a crBox 2 and 3ManufactiBox 4Generic aBox 5ReferenceBox 6Enter detaBox 7If the PID reasons frBox 8The box s occurrenceBox 9This box a in manufar requiremeBox 10Details er has been not been a alternativa be made a the EvaluiBox 11Enter theBox 12To be use in the releBox 13Fill table a Box 15Box 16Fill in Tab	he serial number and the suffix of the form. ride details given in table; in particular there sha the ESCC code for values tolerances, etc.; the c nter either a cross or the specific characteristic o ross. urer's name and location of plant where the com	all be listed - the variants or range of variants; the range designation given in detail specification as 'based on';	of components -under Test
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Box 5ReferenceBox 6Enter detaBox 7If the PID reasons forBox 8The box so occurrenceBox 9This box of in manufarequiremedBox 10Details er has been not been alternative be made in the EvalueBox 11Enter the Box 12Box 13Fill table a OCULBox 14Fill in any QML entreBox 15All Execu QML entre	ind detail specifications used during qualification	nponents were manufactured and tested.	
Box 6Enter detaBox 7If the PID reasons forBox 8The box s occurrenceBox 9This box 4 in manufarequiremeBox 10Details er has been not been alternative be made to the EvalueBox 11Enter theBox 12To be used in the releaBox 13Fill table aBox 14Fill in anyBox 15All Execu QML entreBox 16Fill in Table		n program.	
Box 7If the PID reasons for reasons for soccurrenceBox 8The box s occurrenceBox 9This box of in manufar requirementBox 10Details er has been not been a alternative be made i the EvalueBox 11Enter the Box 12Box 12To be use in the releBox 13Fill table a Box 14Box 15All Execut QML entrBox 16Fill in Table	e to test report(s) submitted in support of applica	ation.	
Box 8The box s occurrenceBox 9This box of in manufarequiremedBox 10Details er has been not been alternative be made i the EvalueBox 11Enter the Box 12Box 12To be use in the releBox 13Fill table a QML entrBox 16Fill in Table	ails to identify the PID that was applicable at the	e time the qualification lot was manufactured.	
Box 9This box of in manufa requirementBox 10Details er has been not been a alternative be made it the EvaluitBox 11Enter the Sox 12Box 12To be use in the releBox 13Fill table a Box 14Box 15All Execu- QML entrBox 16Fill in Table	was evolved after qualification lot manufacture, or changes. Major changes shall be clearly mar	<ul> <li>adequate details of such evolution shall be provided to rked.</li> </ul>	gether with
in manufa requireme Box 10 Details er has been not been de the Evalue Box 11 Enter the Box 12 To be use in the rele Box 13 Fill table a Box 14 Fill in any Box 15 All Execu- QML entr Box 16 Fill in Tab		tive Representative that has verified it together with the	date of this
has been not been not been the EvalueBox 11Enter the EvalueBox 12To be use in the releBox 13Fill table a Fill in anyBox 14Fill in anyBox 15All Execution QML entreBox 16Fill in Table		he plant to confirm that the practices, procedures, materi e PID. This survey shall be carried out in accordance with d its findings shall be recorded.	
Box 12To be used in the releBox 13Fill table aBox 14Fill in anyBox 15All Execu QML entrBox 16Fill in Table a	performed and that the results thereof are summi- carried out according to established ESCC docu- e data and declare its assessed degree of satisf	aluation program according to ESCC Basic Specification imarized in the survey and test reports. If the evaluation uments, the applicant Executive Representative shall pro factory compliance with the ESCC basic requirements. F (DPA), Failure Analysis and Non conformance (NCCS) i	program has ovide Reference shall
in the rele Box 13 Fill table a Box 14 Fill in any Box 15 All Execu QML entr Box 16 Fill in Tab	name of the Executive Coordinator and the sigr	nature.	
Box 14Fill in anyBox 15All ExecutionQML entrementBox 16Fill in Table	ed when there is a need to expand any of the bo evant Box. Box 12 can be broken into 12a, 12b,	oxes from 1 through 10. Identify box affected and referer etc. if several Boxes have to be expanded.	nce the Box 12
Box 15 All Execu QML entr Box 16 Fill in Tab	as requested.		
QML entr Box 16 Fill in Tab	additional tasks required to achieve full complia	ance.	
		special conditions or restrictions, modifications of the QF red clearly in Box 15, signed by the ESA Representative	
	le as requested.		
Box 17 Confident	tial details of PID changes shall be provided.		
	compliance with reference to specification(s) an rmance shall be sequentially numbered. If releva	nd paragraph(s). To simplify reference in Box 18 each ⁄ant state 'None'	
		re Representative to bring the submitted data to a standar or the reason(s) to accept the nonconformance.	ard likely to be
Box 20 Additional	Commonto		